Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination SAYEH ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|-----|--|-----------------|---------------|---------------------------------------|
| * | Α | US-6,326,910 | 12-2001 | Hayduk et al. | 341/137 |
| * | В | US-6,525,682 | 02-2003 | Yap et al. | 341/137 |
| * | С | US-6,781,533 | 08-2004 | Yap et al. | 341/143 |
| * | D | US-6,469,649 | 10-2002 | Helkey et al. | 341/155 |
| | Ε | US- | | | |
| | F | US- | | | · · · · · · · · · · · · · · · · · · · |
| | G | US- | | | |
| | Н | US- | | | |
| | ı | US- | | | |
| | · J | US- | | | |
| | К | US- | | | |
| | L | US- | | · | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | | |
|---|---|---|--|--|--|--|--|
| | U | | | | | | |
| | V | | | | | | |
| | w | | | | | | |
| | x | | | | | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.